## Application/Control No. Applicant(s)/Patent Under Reexamination 09/887,854 BANKIEWICZ ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Shin-Lin Chen 1632 **U.S. PATENT DOCUMENTS** Document Number Date Country Code-Number-Kind Code MM-YYYY Name Classification Α US-В US-С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ US-US-US-FOREIGN PATENT DOCUMENTS Document Number Date Country Code-Number-Kind Code Country MM-YYYY Name Classification Ν 0 Ρ Q R

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